

DATA SHEET

SURFACE MOUNT MULTILAYER CERAMIC CAPACITORS

Automotive grade with Soft Termination

X7R

I nF to 4.7 uF

RoHS compliant & Halogento Free



YAGEO Phi(comp



SCOPE

This specification describes Automotive grade X7R series chip capacitors with flexible leadfree terminations and used for automotive equipments.

APPLICATIONS

All general purpose applications Entertainment applications Comfort / security applications Information applications

FEATURES

- · AEC-Q200 qualified
- MSL class: MSL I
- AC series soldering is compliant with J-STD-020D
- Halogen free epoxy
- RoHS compliant
- · Reduce environmentally hazardous waste
- · High component and equipment reliability
- Save PCB space
- The capacitors are 100% performed by automatic optical inspection prior to taping.

ORDERING INFORMATION - GLOBAL PART NUMBER

All part numbers are identified by the series, size, tolerance, TC material, packing style, voltage, process code, termination and capacitance value.

GLOBAL PART NUMBER

AS XXXX X X XXX X B X XXX

(1) (2) (3) (4) (5) (6) (7)

(I) SIZE - INCH BASED (METRIC)

0805 (2012) / 1206 (3216)/ 1210 (3225)

(2) TOLERANCE

 $J = \pm 5\%$

 $K = \pm 10\%$

 $M = \pm 20\%$

(3) PACKING STYLE

R = Paper/PE taping reel; Reel 7 inch

K = Blister taping reel; Reel 7 inch

P = Paper/PE taping reel; Reel 13 inch

F = Blister taping reel; Reel 13 inch

(4) TC MATERIAL

X7R

(5) RATED VOLTAGE

8 = 25 V

9 = 50 V

0 = 100 V

A = 200 V

Y = 250 V

(6) PROCESS

B = Class 2 MLCC

(7) CAPACITANCE VALUE

2 significant digits+number of zeros

The 3rd digit signifies the multiplying factor, and letter R is decimal point

Example: $121 = 12 \times 10^{1} = 120 \text{ pF}$

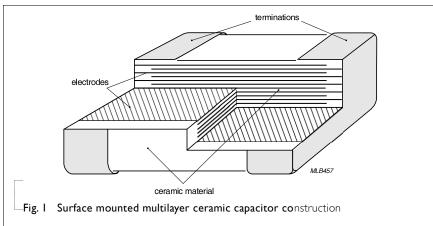


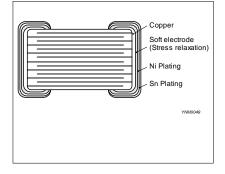
CONSTRUCTION

The capacitor consists of a rectangular block of ceramic dielectric in which a number of interleaved metal electrodes are contained. This structure gives rise to a high capacitance per unit volume.

The inner electrodes are connected to the two end flexible terminations and finally covered with a layer of plated tin (NiSn).

The terminations are lead-free. A cross section of the structure is shown in Fig.1 and Fig.2.



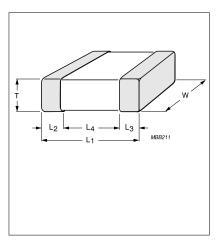


DIMENSION

Table I For outlines see fig. 3

TYPE	LI (mm)	W (mm)	T (mm)	L2/L3(mm) min	L2/L3(mm) max	L4(mm) min
0805	2.0 + 0.3	1.25 + 0.2	0.85 ± 0.15	0.25	0.75	0.70
	2.0 ± 0.3	1,25 ± 0,2	1.25 ± 0.20			0.70
			0.85 ± 0.15			
1206	1206 3.2 ± 0.4	1.6 ± 0.2	1.25 ± 0.20	0.25	0.85	1.50
			1.60 ± 0.20	-		
1210	3.2 ± 0.5	2.5 ± 0.3	2.5 ± 0.3	0.25	1.00	1.20

OUTLINES





CAPACITANCE RANGE & THICKNESS FOR X7R

Table 2	Size 0805					
CAP.		0805				
		10 V	16 V	25 V	50 V	100 V
	I.O nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15
	1.5 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15
	2.2 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15
	3.3 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15
	4.7 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15
	6.8 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15
	10 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15
	15 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15
	22 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15
	33 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	1.25±0.2
	47 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	1.25±0.2
	68 nF	0.85±0.15	0.85±0.15	0.85±0.15	1.25±0.2	1.25±0.2
	100 nF	0.85±0.15	0.85±0.15	0.85±0.15	1.25±0.2	1.25±0.2

NOTE

Values in shaded cells indicate thickness class in mm

CAPACITANCE RANGE & THICKNESS FOR X7R

Table 3 Size 1206

CAP.

1206

	6.3 V	10V	16V	25V	50 V	100 V	250 V
22 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	1.25±0.2
33 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	1.25±0.2
47 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	1.25±0.2
68 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	1.25±0.2	1.25±0.2
100 nF	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	0.85±0.15	1.25±0.2	1.6±0.2
150 nF	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2	
220 nF	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2	

Table 4 Size 1210

CAP.

1210

50 V

4.7 uF 2.5±0.3

NOTE

Values in shaded cells indicate thickness class in mm

THICKNESS CLASSES AND PACKING QUANTITY

Table 5

SIZE	THICKNESS	TAPE WIDTH	Ø180	MM / 7 INCH	Ø330 MM / 13 INCH		
CODE	CLASSIFICATION	QUANTITY PER REEL	Paper	Blister	Paper	Blister	
0805	0.85 ±0.15 mm	8 mm	4,000		15,000		
0003	1.25 ±0.2 mm	8 mm		3,000		10,000	
	0.6 ±0.1 mm	8 mm	4,000		20,000		
1206	0.85 ±0.1 mm	8 mm	4,000		15,000		
1200	1.25 ±0.2 mm	8 mm		3,000		10,000	
	1.6 ±0.2 mm	8 mm		2,000		10,000	
1210	2.5 ±0.3 mm	8 mm		1,000			

ELECTRICAL CHARACTERISTICS

NP0/X7R DIELECTRIC CAPACITORS; NI/SIN TERMINATIONS

Unless otherwise specified, all test and measurements shall be made under standard atmospheric conditions for testing as given in 5.3 of IEC 60068-1:

- Temperature: 15 °C to 35 °C - Relative humidity: 25% to 75% - Air pressure: 86 kPa to 106 kPa

Before the measurements are made, the capacitor shall be stored at the measuring temperature for a time sufficient to allow the entire capacitor to reach this temperature.

The period as prescribed for recovery at the end of a test is normally sufficient for this purpose.

Table 6				
DESCRIPTION				VALUE
Capacitance range				I nF to 4.7 uF
Capacitance tolerance				
X7R				±5% ⁽¹⁾ , ±10%, ±20%
Dissipation factor (D.F.)				
X7R	0805	1206	1210	
≤10V	InF to 100uF	22nF to 200nF		≤ 5%
16V	InF to 100nF	22nF to 200nF		≤ 3.5%
	680nF to TuF			≤ 5%
25V	InF to 100nF	22nF to 200nF		≤ 2.5%
50V	InF to 100nF	22nF to 220nF		≤ 2.5%
	220nF to 470nF			≤ 3.5%
			4.7 uF	≤ 5%
100V	InF to 100nF	22nF to 220nF		≤ 2.5%
				≤ 5%
250V		22nF to 100nF		
Insulation resistance after I minute at U_r (DC)			IR ≥ 10 GΩ or I.R × C ≥	500Ω.F whichever is less
Maximum capacitance change as a function of temperature (temperature characteristic/coefficient):				±15%
Operating temperature range: X7R				−55 °C to +125 °C

NOTE

1. Capacitance tolerance ±5% doesn't available for X7R full product range, please contact local sales force before order

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SOLDERING RECOMMENDATION

SOLDERING	SIZE				
METHOD	0402	0603	0805	1206	≥ 1210
Reflow	≥ 0.1 µF	≥ 1.0 µF	≥ 2.2 µF	≥ 4.7 µF	Reflow only
Reflow/Wave	< 0.1 µF	< 1.0 µF	< 2.2 µF	< 4.7 µF	

SOLDERING CONDITIONS

The lead free MLCCs are able to stand the reflow soldering conditions as below:

- Temperature: above 220 °C
- Endurance: 95 to 120 seconds
- Cycles: 3 times

The test of "soldering heat resistance" is carried out in accordance with the schedule of "MIL-STD-202F-method 210F", "The robust construction of chip capacitors allows them to be completely immersed in a solder bath of 270 °C for 10 seconds". Therefore, it is possible to mount MLCCs on one side of a PCB and other discrete components on the reverse (mixed PCBs). Surface Mount Capacitors are tested for solderability at 245 °C during 2 seconds. The test condition for no leaching is 260°C for 30 seconds.

TESTS AND REQUIREMENTS

Table 8 Test procedures and requirements

TEST	TEST METHOD		PROCEDURE	REQUIREMENTS	
Mounting	IEC 60384- 21/22	4.3	The capacitors may be mounted on printed-circuit boards or ceramic substrates	No visible damage	
Capacitance	IEC 60384- 21/22	4.5.1	Class I: At 20°C, 24 hours after annealing $f = 1$ MHz for $C \le InF$, measuring at voltage $I \lor_{rms}$ at 20°C $f = 1$ KHz for $C > InF$, measuring at voltage $I \lor_{rms}$ at 20°C Class 2: At 20°C, 24 hours after annealing $f = 1$ KHz, measuring at voltage $I \lor_{rms}$ at 20°C	Within specified tolerance	
Dissipation Factor (D.F.)	IEC 60384- 21/22	4.5.2	Class I: At 20°C, 24 hours after annealing $f = 1 \text{ MHz for C} \leq \text{InF, measuring at voltage I V}_{rms} \text{ at } 20^{\circ}\text{C}$ $f = 1 \text{ KHz for C} > \text{InF, measuring at voltage I V}_{rms} \text{ at } 20^{\circ}\text{C}$ Class 2: At 20 °C, 24 hours after annealing $f = 1 \text{ KHz, measuring at voltage I V}_{rms} \text{ at } 20^{\circ}\text{C}$	In accordance with specification	
Insulation Resistance	IEC 60384- 21/22	4.5.3	At U _r (DC) for I minute	In accordance with specification	



REQUIREMENTS <General purpose series>

 Δ C/C: \pm 30ppm

X7R: Δ C/C: $\pm 15\%$

<High Capacitance series>

X7R/X5R: Δ C/C: \pm 15%

Class I:

Class2:

TEST

coefficient

TEST METHOD

Temperature

PROCEDURE

Capacitance shall be measured by the steps shown in the following table.

The capacitance change should be measured after 5 min at each specified temperature stage.

Step	Temperature(°C)
a	25±2
b	Lower temperature±3°C
С	25±2
d	Upper Temperature±2°C
е	25±2

(I) Class I

Temperature Coefficient shall be calculated from the formula

Temp, Coefficient =
$$\frac{C2 - C1}{C1 \times \Delta T} \times 10^6 \text{ [ppm/°C]}$$

C1: Capacitance at step c

C2: Capacitance at 125°C

ΔT: 100°C (=125°C -25°C)

(2) Class II

Capacitance Change shall be calculated from the formula as

$$\Delta C = \frac{C2 - C1}{C1} \times 100\%$$

C1: Capacitance at step c

C2: Capacitance at step b or d

High Temperature Exposure

AEC-Q200

3 Unpowered; 1000hours@T=150°C

Measurement at 24±2 hours after test conclusion.

No visual damage

 Δ C/C :

Class I:

NP0: within $\pm 0.5\%$ or 0.5 pF

whichever is greater

Class2:

X7R: ±10%

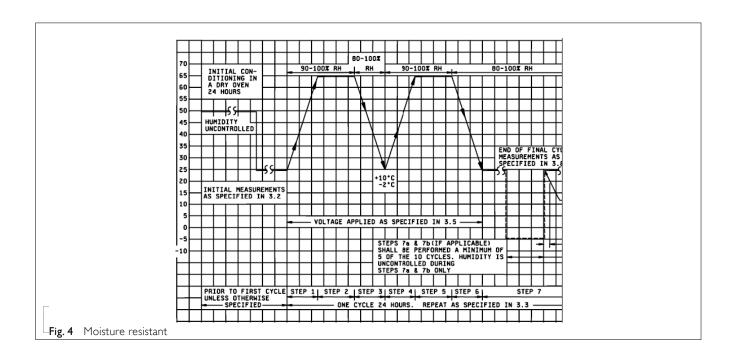
D.F.:

within initial specified value

within initial specified value



TEST	TEST METH	HOD	PROCEDURE	REQUIREMENTS
Temperature Cycling	AEC-Q200	4	Preconditioning; I50 +0/–I0°C for I hour, then keep for	No visual damage
			24 ± 1 hours at room temperature	ΔC/C
			1000 cycles with following detail: 30 minutes at lower category temperature 30 minutes at upper category temperature Recovery time 24 ±2 hours	Class 1: NP0: Within ±1% or 0.5pF, whichever is greater. Class 2: X7R: ±10%
				D.F. meet initial specified value IR meet initial specified value
Destructive Physical Analysis	AEC-Q200	5	10ea X 3 lots. Note: Only applies to SMD ceramics. Electrical test not required.	
Moisture Resistance	AEC-Q200	6	T=24 hrs/per cycle; 10 continuous cycles unpowered. Measurement at 24 ± 2 hours after test condition.	No visual damage
				ΔC/C NP0: Within ±3% or 3 pF, whichever is greater X7R: ±10%
				D.F. Within initial specified value IR NP0: \geq 10,000 M Ω X7R: Meet initial specified value





TEST	TEST METH	HOD	PROCEDURE	REQUIREMENTS
Biased Humidity	AEC-Q200	7	 Preconditioning, class 2 only: 150 +0/-10 °C /1 hour, then keep for 24 ±1 hour at room temp 	No visual damage after recovery
			 Initial measure: Parameter: IR Measuring voltage: 1.5V ± 0.1 VDC Note: Series with 100 KΩ & 6.8 KΩ Test condition: 85 °C, 85% R.H. connected with 100 KΩ resistor, applied 1.5V/U_r for 1,000 hours. Recovery: Class 1: 6 to 24 hours Class 2: 24 ± 2 hours Final measure: IR 	Initial requirement: Class I: - Connected to $100 \text{ K}\Omega$: $C \le 10 \text{ nF: } 1.\text{R} \ge 10,000 \text{ M}\Omega$ or $C > 10 \text{ nF: } (1.\text{R-}100 \text{ K}\Omega) \times C$ $\ge 100\text{s.}$ - Connected to $6.8 \text{ K}\Omega$: $C \le 10 \text{ nF: } 1.\text{R} \ge 10,000 \text{ M}\Omega$ or $C > 10 \text{ nF: } (1.\text{R-}6.8 \text{ K}\Omega) \times C$ $\ge 100\text{s.}$ Class 2: - Connected to $100 \text{ K}\Omega$: $C \le 25 \text{ nF: } 1.\text{R} \ge 4,000 \text{ M}\Omega$ or $C > 25 \text{ nF: } (1.\text{R-}100 \text{ K}\Omega) \times C$ $\ge 100\text{s.}$ - Connected to $6.8 \text{ K}\Omega$: $C \le 25 \text{ nF: } 1.\text{R} \ge 10,000 \text{ M}\Omega$ or $C > 25 \text{ nF: } 1.\text{R} \ge 10,000 \text{ M}\Omega$ or $C > 25 \text{ nF: } (1.\text{R-}6.8 \text{ K}\Omega) \times C$ $\ge 100\text{s.}$ Final measurement: The insulation resistance shall be greater than 0.1 time initial value.



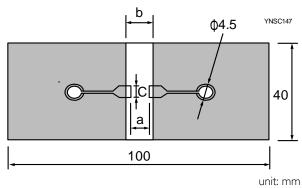
TEST	TEST METH	IOD	PROCEDURE	REQUIREMENTS
Operational Life	AEC-Q200	8	 Preconditioning, class 2 only: 150 +0/-10 °C /I hour, then keep for 24 ± I hour at room temp Initial measure: Spec: refer to initial spec C, D, IR Endurance test: Temperature: X7R: 125 °C Specified stress voltage applied for I,000 hours: Applied 2.0 × U_r for general products Applied I.5 × U_r for high cap. Products High voltage series follows with below stress condition: Applied I.5 × Ur for 200V, 250V series Applied I.3 × Ur for 500V, 630V series Applied I.2 × Ur for IKV, 2KV, 3KV series Recovery time: 24 ±2 hours Final measure: C, D, IR Note: If the capacitance value is less than the minimum value permitted, then after the other measurements have been made the capacitor shall be preconditioned according to "IEC 60384 4.1" and then the requirement shall be met. 	No visual damage
External Visual	AEC-Q200	9	Any applicable method using × 10 magnification	In accordance with specification
Physical Dimension	AEC-Q200	10	Verify physical dimensions to the applicable device specification.	In accordance with specification
Mechanical Shock	AEC-Q200	13	Three shocks in each direction shall be applied along the three mutually perpendicular axes of the test specimen (18 shocks) Peak value: 1,500 g's Duration: 0.5 ms Velocity change: 15.4 ft/s Waveform: Half-sin	ΔC/C NP0: Within ±0.5% or 0.5 pF, whichever is greater X7R: ±10% D.F. Within initial specified value IR Within initial specified value
Vibration	AEC-Q200	14	5 g's for 20 minutes, 12 cycles each of 3 orientations. Note: Use 8" × 5" PCB. 0.31" thick 7 secure points on one long side and 2 secure points at comers of opposite sides. Parts mounted within 2" from any secure point. Test from 10-2000 Hz.	ΔC/C NP0: Within ±0.5% or 0.5 pF, whichever is greater X7R: ±10% D.F: meet initial specified value IR meet initial specified value

TEST	TEST METH	HOD	PROCEDURE	REQUIREMENTS
Resistance to Soldering Heat	AEC-Q200	15	Precondition: $ 50 \pm 0/-10 \degree C $ for I hour, then keep for 24 ± 1 hours at room temperature Preheating: for size ≤ 1206 : $ 20 \degree C $ to $ 50 \degree C $ for I minute Preheating: for size ≥ 1206 : $ 00 \degree C $ to $ 20 \degree C $ for I minute and $ 70 \degree C $ to $ 200 \degree C $ for I minute Solder bath temperature: $ 260 \pm 5 \degree C $ Dipping time: $ 10 \pm 0.5 $ seconds Recovery time: $ 24 \pm 2 $ hours	Dissolution of the end face plating shall not exceed 25% of the length of the edge concerned $\Delta C/C$ Class I: NP0: Within ±1% or 0.5 pF, whichever is greater. Class2: X7R: ±10% D.F. within initial specified value
				IR within initial specified value
Thermal Shock	AEC-Q200	16	1. Preconditioning, class 2 only:	No visual damage
	150 +0/-10 °C /I hour, then keep for 24 ±1 hour at roor temp 2. Initial measure: Spec: refer to initial spec C, D, IR 3. Rapid change of temperature test: NP0/X7R: -55 °C to +125 °C; 300 cycles 15 minutes at lower category temperature; 15 minutes at upper category temperature. 4. Recovery time: Class1: 6 to 24 hours Class2: 24 ±2 hours	temp 2. Initial measure: Spec: refer to initial spec C, D, IR	ΔC/C NP0: Within ±1% or 1 pF, whichever is greater X7R: ±15%	
			15 minutes at lower category temperature; 15 minutes at	D.F: meet initial specified value IR meet initial specified value
			Class I: 6 to 24 hours	
			5. Final measure: C, D, IR	
ESD	AEC-Q200	17	Per AEC-Q200-004	A component passes a voltage level if all components stressed at that voltage level pass. HBM > 4kV
Solderability	AEC-Q200	18	Preheated to a temperature of 80 °C to 140 °C and maintained for 30 seconds to 60 seconds.	The solder should cover over 95% of the critical area of each termination.
			Test conditions for lead containing solder alloy	terrination,
			Temperature: 235 ±5 °C Dipping time: 2 ±0.2 seconds Depth of immersion: 10 mm	
			Alloy Composition: 60/40 Sn/Pb	
			Number of immersions: I	
			Test conditions for lead-free containing solder alloy	
			Temperature: 245 ±5 °C	
			Dipping time: 3 ±0.3 seconds Depth of immersion: 10 mm	
			Alloy Composition: SAC305	
			Number of immersions: I	



TEST	TEST METHOD		PROCEDURE	REQUIREMENTS	
Electrical Characterization	AEC-Q200	19	Parametrically test per lot and sample size requirements, summary to show Min, Max, Mean and Standard deviation at room as well as Min and Max operating temperatures.	ΔC/C Class I: NP0: ±30 ppm/°C	
			Class 1: NP0: -55 °C to +125 °C Normal temperature: 20 °C Class 2: X7R: -55 °C to +125 °C Normal temperature: 20 °C	Class2: X7R: ±15%	
Board Flex	AEC-Q200	21	Part mounted on a 100 mm X 40 mm FR4 PCB board, which is 1.6 ±0.2 mm thick and has a layer-thickness 35 µm ± 10 µm. Part should be mounted using the following soldering reflow profile. Conditions: Class2: Bending 5 mm at a rate of 1 mm/s, radius jig 230 mm	No visible damage ΔC/C Class2: X7R: ±10%	

Test Substrate:



	Dimension(mm)				
Туре	а	b	С		
0201	0.3	0.9	0.3		
0402	0.4	1.5	0.5		
0603	1.0	3.0	1.2		
0805	1.2	4.0	1.65		
1206	2.2	5.0	1.65		
1210	2.2	5.0	2.0		
1808	3.5	7.0	3.7		

Terminal	
Strength	

AEC-Q200 22 With the component mounted on a PCB obtained with the device to be tested, apply a 17.7N (1.8Kg) force to the side of a device being tested.

This force shall be applied for 60+1 seconds.

Also the force shall be applied gradually as not to apply a shock to the component being tested.

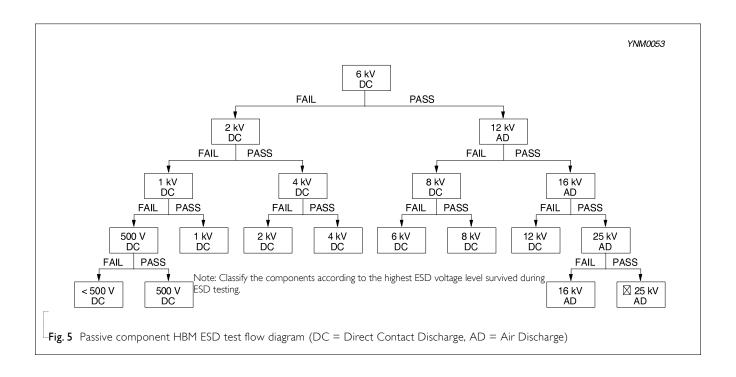
* Apply 2N force for 0402 size.

Magnification of 20X or greater may be employed for inspection of the mechanical integrity of the device body, terminals and body/terminal junction.

Before, during and after the test, the device shall comply with all electrical requirements stated in this specification.



TEST	TEST METHOD		PROCEDURE	REQUIREMENTS	
Beam Load Test	AEC-Q200	23	Place the part in the beam load fixture. Apply a force until the part breaks or the minimum acceptable force level required in the user specification(s) is attained.	\leq 0805 Thickness $>$ 0.5 mm: 20N Thickness \leq 0.5 mm: 8N \geq 1206 Thickness \geq 1.25 mm: 54N Thickness $<$ 1.25 mm: 15N	
Voltage Proof	IEC 60384-I	4.6	Specified stress voltage applied for $1 \sim 5$ seconds Ur ≤ 100 V: series applied 2.5 Ur 100 V $<$ Ur ≤ 200 V series applied (1.5 Ur + 100) 200 V $<$ Ur ≤ 500 V series applied (1.3 Ur + 100) Ur > 500 V: 1.3 Ur Ur ≥ 1000 V: 1.2 Ur Charge/Discharge current is less than 50 mA	No breakdown or flashover	





Product specification 16

Surface-Mount Ceramic Multilayer Capacitors | Automotive grade | NP0/X7R | 6.3 V to 630 V

REVISION HISTORY

REVISION DATE CHANGE NOTIFICATION DESCRIPTION

Oct. 05, 2017 Version 0 - New

NP0/X7R 6.3 V to 630 V

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